Ministry of Supply - D.L.R.D./S.R.D.E. <u>VALVE ELECTRONIC</u> CV4O93

Specification MCS/CV4093	SEC	URITY
Issue 1, Dated 8.1.59 To be read in conjunction with K.1001, BS448 and BS1409	Specification Unclassified	<u>Valve</u> Unclassified

----→ Indicates a change

Type of Valve - Reliable H.F. Beam Tetrode	Sharp			MARI	CING	
Cut Off Cathode - Directly Heated Envelope - Glass Metallised Prototype - VX9185	See K. 1001/4, except that the valve shall only be marked with the CV Number Factory and Date Code.					
RATING (All limiting values are absolute) Filament Voltage (V)	1.25	NOTE	See App. 1 t BS 448/B5G/F	BAS o CV		
Filament Current (mA) Max. Anode Voltage (V) Max. Screen Voltage (V)	20 100 100		CONNECTIONS			
Anode Impedance (MO) Max. Bulb Temperature (°C) Max. Shock (Short Duration) (g)	1.0 100 450		PIN		RLECTR	ODE
Max. Acceleration (Continuous Operation) (g)	5		1 2		(red d (-), b	
Typical Operating Conditions Measured at Va = Vg ₂ = 67.5V			3 4 5		(-), b	
Measured at $Va = Vg_2 = 67.5V$ $Vg_1 = 0, Rg_1 = 5 M\Omega$ Anode Current Screen Current Mutual Conductance (mA) (mA)	1.8 0.5 1.1		D See App. 1 t See BS448/B5 Size Ref. No			
Capacitances (pF) Cin (nom.) Cout (nom.)	3•7 4•6		Dimension (millimetr		Min.	Max.
Ca, g ₁ (max.)			A. Overal Length Diameter B. Minor C. Major Lead Lengt		- - - 38•1	38.15 7.264 9.804
			MOUNTING POSITION ANY			<u>ON</u>



TESTS

To be performed in addition to those applicable in K.1001. Tests shall be performed in the specified order unless otherwise agreed with the Inspecting Authority.

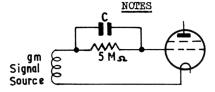
Test conditions - unless otherwise specified $Vf(V)$ $Va(V)$ $Vg_2(V)$ $Vg_1(V)$ Rg_1 (Megohms) 1.25 67.5 67.5 0 5									
W 4004		m - 1 (2 - 244)	AQL	Insp.	AOI, Insp.	Sym-	Lin	its	
K. 1001 Ref.	Test	Test Conditions	%	Level	bol	Min.	Max.	Units	
7•1	Glass Strain	No voltages	6.5	I					
	GROUP A								
	Electrode Insulation	Vg ₁ - all = -100V Vg ₂ - all = -100V Va - all = -100V Vf = 0		100% 100% 100%	R R R	100 100 100		MΩ MΩ MΩ	
	Reverse Grid Current	$Vg_1 = -0.5V$		100%	Ig ₁	-	0.5	μА	
	Contact Polential	Rg = 0.1 MM max. Vfz 1.25V, VazVgzzo, Vg1z1.8V Hungh 200k		100%	+ Tg 1	0.25	4	MA	
	GROUP B	Combined AQL	1.0	11					
	Filament Current		0.65	11	If	18	22	m.A.	
	Anode Current		0.65	11	Ia	1•2	2•4	m,A	
	Screen Grid Current		0.65	II	Ig ₂	0.35	0•7	m.A.	
	Mutual Conductance (1)	Note 1	0.65	11	gm	0•75	1.45	mA/V	
	GROUP C	Combined AQL	4.0	I					
	Mutual Conductance (2)	Note 1 Vf = 1.0V	2•5	I	gm	0.60	1•45	mA/V	
	Mutual Conductance (3)	Note 1 Vf = 1.0V Take reading after 15 minutes	2•5	I	gm	0.60	1•45	mA/V	
5•12	GROUP D Lead Fragility		6•5	IA					
	Filament Anode Short	Note 2		T.A.					
	Capacitance	Measured on a 1 Mc/s bridge with the valve mounted in a fully screened socket. No shield.	6•5	IC	Ca,g ₁ Cin Cout	3.0 3.7 3.	0.01 4.4 5.5	pf pf pf	

K•1001			AQL	Insp.	Sym-	Lim	its	Units
Ref.	Test	Test Conditions	%	Level	bol	Min.	Max.	
	GROUP D (Cont'd) Functional Test			Т.А.		opera		
11•3	GROUP E Fatigue	Acceleration = 5g peak min. Time = 99 hrs. Note 3		IA				
	Post Fatigue Tests					2 (2		
	Mutual Conductance (1)	Note 1	2•5		gm	0.60		mA/V
11-4	Shock	Hammer Angle 30° No voltages		IA				
	Post Shock Tests							
	Mutual Conductance (1)	Note 1	2•5	gma		0.60		mA/V
A VI/	GROUP F Life							
A VI/ 5•1	Stability Life Test							
	Mutual Conductance (2)	Note 1 Vf = 1.0V	1.0	I	gm	0.60		mA/V
A VI/ 5•3	Intermittent Life Test							
	Life Test End Point (500 hrs.)	Combined AQL	6.5	IA				
A VI/ 5.6	Inoperatives Mutual Conductance (1)	Note 1	2•5 2•5		gm	0.60		mA/V
	Electrode Insulation	Vf = 0 Vg ₁ - all = -100V Vg ₂ - all = -100V Va - all = -100V	4.0		R R R	50 50 50		ΜΩ ΜΩ ΜΩ

CV4093

K•1001			AQL	AQL Insp. % Level	Sym-	Limits		Units
Ref.	Test Conditions	Я	bol		Min.	Max.	ONIUS	
	GROUP F (Cont'd) Life Test End Point 1,000 hrs.	Combined AQL	10	IA				
A VI/	Inoperatives		4.0					
5.6	Mutual Conductance (1)	Note 1	4.0		gm	0.60		mA/V
	Reverse Grid	As in Group A	4.0		Ig ₁	-	1.0	μΑ
	Current Electrode	As in Group A	6.5		+ I3,	To be	recorded	MA
	Insulation	Vg ₁ - all = -100V Vg ₂ - all = -100V Va - all = -100V			R R R	30 30 30		MCU MCU
A IX/ 2.4 & 2.5	GROUP G Electrical Retest after 28 days holding period			100%				
A VI/ 5.6	Inoperatives		0.5					
	Mutual Conductance (1)	Note 1			gm	0.75	1•45	mA/V
	Reverse Grid Current	As in Group A	0.5		Ig ₁	-	0.5	μA

1. Test in circuit



Rypass capacity C shall have a resistance of less than 20,000 ohms at the test frequency.

- 2. Raise V_f until filament opens. Test for filament to anode short only. After performance of the filament burn out test, if the short circuit shall pass in excess of five times the rated filament current without burning out the short circuit, the valve shall be deemed a failure. This test shall be performed by a Service Laboratory on three valves which shall be in addition to the required number for Type Approval samples. Manufacturer's data are not required for this test.
- Filament voltage and H.T. voltage are switched simultaneously 1 min. on 3 min. off throughout the duration of the test. Frequency = 170 cps. The valves to be vibrated in each of three mutually perpendicular planes in turn for periods of 30, 30 and 39 hours. One plane to include the longitudinal axis of the valve.

SPECIFICATION MOS/CV4093

ISSUE 1, DATED 8.1.59

AMENDMENT No. 1.

Page 2, Group A

Add a new test as follows:-

N.B

Test	Test Conditions	AQL	Insp.	Symbol	Lim:	its	Units
Contact Potential	Vf = 1.25 V Va = Vg2 = 0 Vg1 = 1.8 V through 200 k		100%	+ Igl		0.25	uA

Page 4, Group F, Life Test End Point 1,000 hours.

Add a new test as follows:-

Contact Potential As in Group A	+ Igl	To be recorded	uA
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T.V.C. for S.R.D.E.

May, 1959.

Z.19201.

ELECTRONIC VALVE SPECIFICATIONS

SPECIFICATION MOS/CV 4093 ISSUE 1 DATED 8.1.59

AMENDMENT NO. 2

Page 2 GROUP D, Capacitance
On bottom line of page, in column headed "Limits Min."

Amend figure against "Cout" from 3.7 to 3.5.

· AMS 17.

May 1960. T.V.C. for S.R.D.E. N.17175/D.

ELECTRONIC VALVE SPECIFICATIONS

SPECIFICATION MOS/CV4093 ISSUE 1 DATED 8.1.1959

AMENDMENT NO. 3

Page 3 GROUP D (Continued)

Functional Test.

In remark at right hand side of page delete "A40 and"

T.V.C. for S.R.D.E.

December 1960

N 46654/D

ELECTRONIC VALVE SPECIFICATION

CV4093 Issue 1 dated 8.1.59 AMENDMENT No. 4

Page 1 Base

Delete:- See Appendix I to CV2237

Dimensions

Delete: - See Appendix I to CV2237 Signals Radio Development

DECEMBER 1961

(7732)

28. 2.62 Smith

Establishment.